### February 2004



### FDS4072N3 40V N-Channel PowerTrench<sup>®</sup> MOSFET

### **General Description**

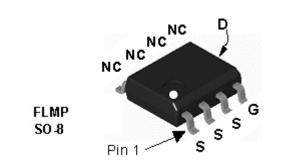
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low  $R_{DS(ON)}$  in a small package.

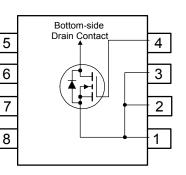
### **Applications**

- Synchronous rectifier
- DC/DC converter

### Features

- 12.4 A, 40 V  $R_{DS(ON)} = 12 \text{ m}\Omega \textcircled{0} V_{GS} = 4.5 \text{ V}$  $R_{DS(ON)} = 10 \text{ m}\Omega \textcircled{0} V_{GS} = 10 \text{ V}$
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- High power and current handling capability
- Fast switching
- FLMP SO-8 package: Enhanced thermal performance in industry-standard package size





### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter			Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage			40	V
V <sub>GSS</sub>	Gate-Source Voltage			± 12	V
I <sub>D</sub>	Drain Curre	nt – Continuous	(Note 1a)	12.4	А
		<ul> <li>Pulsed</li> </ul>		60	
P <sub>D</sub>	Power Dissipation (Note 1			3.0	W
		-	(Note 1b)	1.5	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			–55 to +150	°C
Therma	I Charact	teristics			
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)			40	°C/W
R <sub>eJC</sub>	Thermal Resistance, Junction-to-Case			0.5	°C/W
Packag	e Markin	g and Ordering	g Information		
Device Marking		Device	Reel Size	Tape width	Quantity
FDS4072N3		FDS4072N3	13"	12mm	2500 units

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**Electrical Characteristics**  $T_{A} = 25^{\circ}C$  unless otherwise noted Symbol Parameter Min Max Units **Test Conditions** Тур Drain-Source Avalanche Ratings (Note 2)  $\mathsf{E}_{\mathsf{AS}}$ Drain-Source Avalanche Energy Single Pulse, V<sub>DD</sub> = 20V, I<sub>D</sub>=12.4 A 200 mJ Drain-Source Avalanche Current 12.4 А  $I_{AS}$ **Off Characteristics** Drain–Source Breakdown Voltage 40 V  $\mathsf{BV}_{\mathsf{DSS}}$  $V_{GS} = 0 V$ , I<sub>D</sub> = 250 μA  $I_D$  = 250  $\mu$ A, Referenced to 25°C Breakdown Voltage Temperature 38 mV/°C  $\Delta BV_{DSS}$ Coefficient  $\Delta T_{\rm J}$ Zero Gate Voltage Drain Current V<sub>DS</sub> = 32 V,  $V_{GS} = 0 V$ 1 IDSS μA Gate-Body Leakage, Forward V<sub>GS</sub> = 12 V,  $V_{DS} = 0 V$ 100 nA I<sub>GSSF</sub>  $V_{DS} = 0 V$ Gate-Body Leakage, Reverse  $V_{GS} = -12 V$  , -100 nA  $I_{GSSR}$ On Characteristics (Note 2)  $V_{DS} = V_{GS}$ , Gate Threshold Voltage I<sub>D</sub> = 250 μA 1 1.3 3 V  $V_{\text{GS(th)}}$ Gate Threshold Voltage  $I_D = 250 \ \mu A$ , Referenced to  $25^{\circ}C$ -4.5  $\Delta V_{GS(th)}$ mV/°C **Temperature Coefficient**  $\Delta T_{J}$  $V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 12.4 \text{ A}$ R<sub>DS(on)</sub> Static Drain-Source 9.7 12 mΩ **On-Resistance**  $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 13.7 \text{ A}$ 8.5 10 V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 12.4 A,T<sub>J</sub> = 125°C 14.7 20 Forward Transconductance I<sub>D</sub> = 12.4 A 84 S  $V_{DS} = 10 V$ , **g**<sub>FS</sub> **Dynamic Characteristics** pF  $C_{iss}$ Input Capacitance 4299  $V_{DS} = 20 V$ ,  $V_{GS}$  = 0 V,  $C_{\text{oss}}$ **Output Capacitance** f = 1.0 MHz 351 pF  $C_{\text{rss}}$ pF **Reverse Transfer Capacitance** 149 Switching Characteristics (Note 2)  $V_{DD} = 20 V$ ,  $I_{D} = 1 A$ , Turn-On Delay Time 20 36 t<sub>d(on)</sub> ns V<sub>GS</sub> = 4.5 V,  $R_{GEN}$  = 6  $\Omega$ Turn–On Rise Time 12 22 tr ns Turn-Off Delay Time 52 83 ns t<sub>d(off)</sub> tf Turn-Off Fall Time 18 32 ns  $V_{DS} = 20 V$ ,  $I_{D} = 12.4 \text{ A},$ Qg Total Gate Charge 33 46 nC  $V_{GS} = 4.5 V$ nC Q<sub>gs</sub> Gate-Source Charge 7.8  $\mathsf{Q}_{\mathsf{gd}}$ Gate-Drain Charge nC 8.1 Drain–Source Diode Characteristics and Maximum Ratings Maximum Continuous Drain-Source Diode Forward Current 2.5 А  $I_S$ Drain–Source Diode Forward 0.7 V  $V_{\text{SD}}$  $V_{GS} = 0 V$ ,  $I_{S} = 2.5 A$ (Note 2) 1.2 Voltage trr **Diode Reverse Recovery Time**  $I_{\rm F} = 12.4 \, {\rm A},$ 30 nS  $d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$  $Q_{rr}$ Diode Reverse Recovery Charge 90 nC

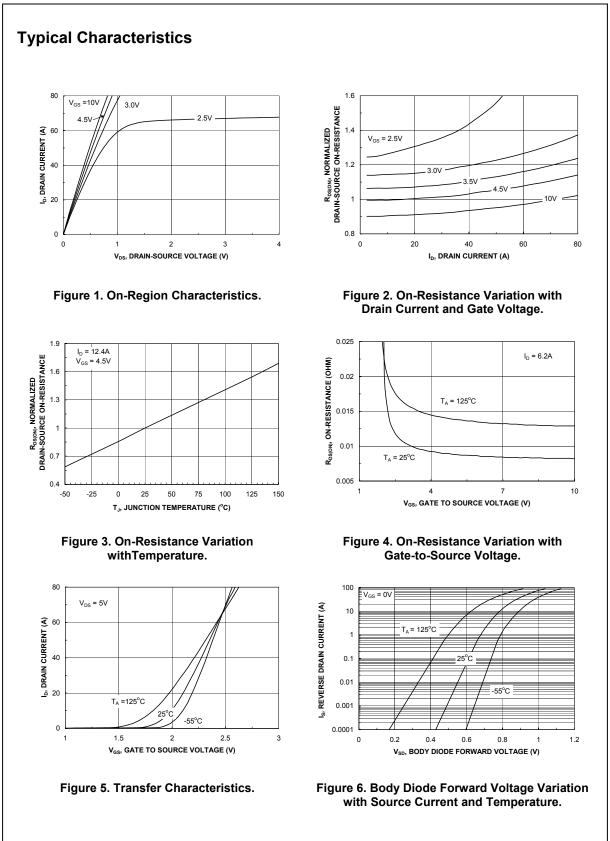
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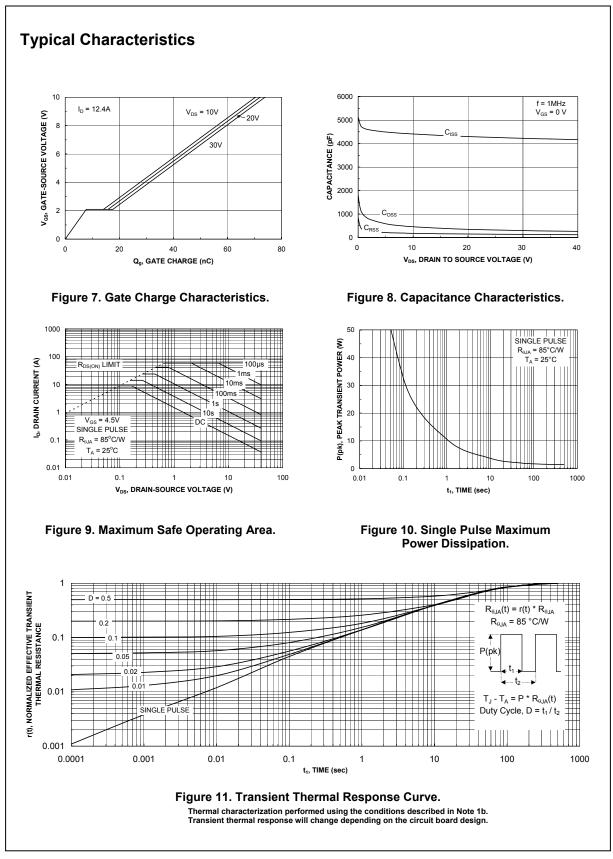
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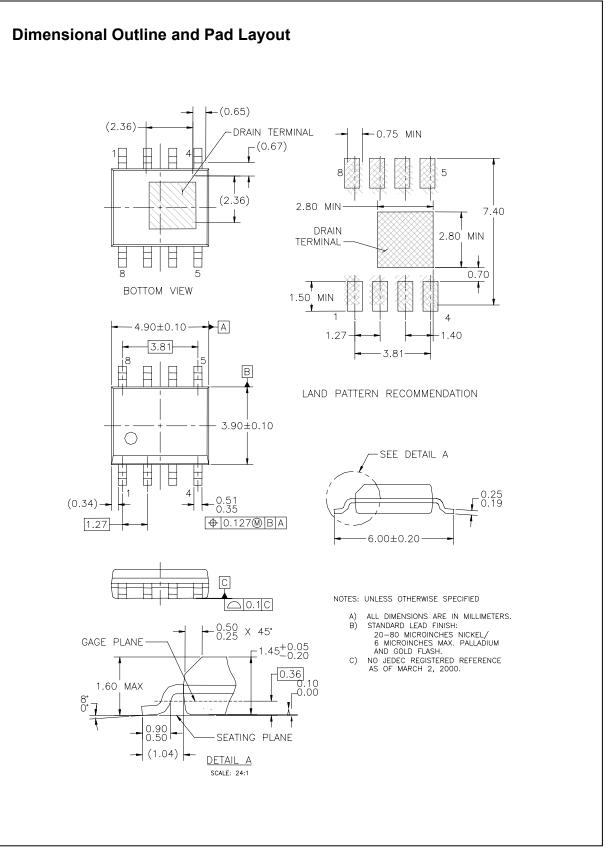
**Electrical Characteristics** 

FDS4072N3 Rev B2 (W)





FDS4072N3 Rev B2 (W)



FDS4072N3 Rev B2 (W)

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